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N-channel TrenchMOS logic level FET

13 July 2012

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel MOSFET in a SOT404 package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

1.2 Features and benefits

- AEC Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True logic level gate with Vgst(th) rating of greater than 0.5V at 175 °C

1.3 Applications

- 12 V Automotive systems
- Motors, lamps and solenoid control
- Start-Stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

1.4 Quick reference data

Table 1. Q	uick reference data						
Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	40	V
I _D	drain current	V _{GS} = 5 V; T _{mb} = 25 °C; <u>Fig. 1</u>	[1]	-	-	120	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>		-	-	324	W
Static chara	cteristics						
R _{DSon}	drain-source on-state resistance	V _{GS} = 5 V; I _D = 25 A; T _j = 25 °C; <u>Fig. 11</u>		-	1.35	1.7	mΩ
Dynamic ch	aracteristics	·					
Q_{GD}	gate-drain charge	$V_{GS} = 5 V; I_D = 25 A; V_{DS} = 32 V;$		-	36.6	-	nC
		<u>Fig. 13; Fig. 14</u>					

[1] Continuous current is limited by package.





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2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	D	drain		
3	S	source		G C C C C C C C C C C C C C C C C C C C
mb	D	mounting base; connected to drain	D2PAK (SOT404)	mbb076 S

3. Ordering information

Table 3. Ordering information							
Type number	Package						
	Name	Description	Version				
BUK961R7-40E	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404				

4. Marking

Table 4. Marking codes	
Type number	Marking code
BUK961R7-40E	BUK961R7-40E

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	40	V
V _{DGR}	drain-gate voltage	R _{GS} = 20 kΩ		-	40	V
V _{GS}	gate-source voltage	T _j = 25 °C; lifetime = 100 hours		-15	15	V
		T _j = 25 °C		-10	10	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 5 V; <u>Fig. 1</u>	[1]	-	120	А
		T _{mb} = 100 °C; V _{GS} = 5 V; <u>Fig. 1</u>	[1]	-	120	А
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \ \mu$ s; Fig. 4		-	1260	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>		-	324	W
T _{stg}	storage temperature			-55	175	°C

BUK961R7-40E

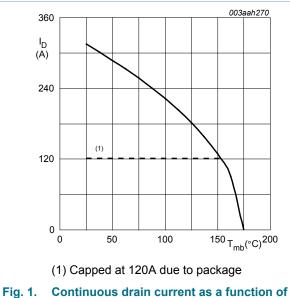
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Symbol	Parameter	Conditions		Min	Max	Unit
Тj	junction temperature			-55	175	°C
Source-drai	in diode					
I _S	source current	T _{mb} = 25 °C	[1]	-	120	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$		-	1260	А
Avalanche i	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 120 \text{ A}; \text{ V}_{sup} \leq 40 \text{ V}; \text{ R}_{GS} = 50 \Omega; \\ \text{ V}_{GS} &= 5 \text{ V}; \text{ T}_{j(init)} = 25 \ ^{\circ}\text{C}; \text{ unclamped}; \\ \hline \text{Fig. 3} \end{split}$	[2][3]	-	801	mJ

[1] Continuous current is limited by package.

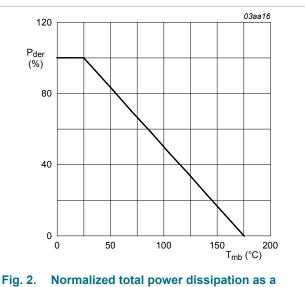
[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

[3] Refer to application note AN10273 for further information.



mounting base temperature

 $V_{GS} \ge 5V$

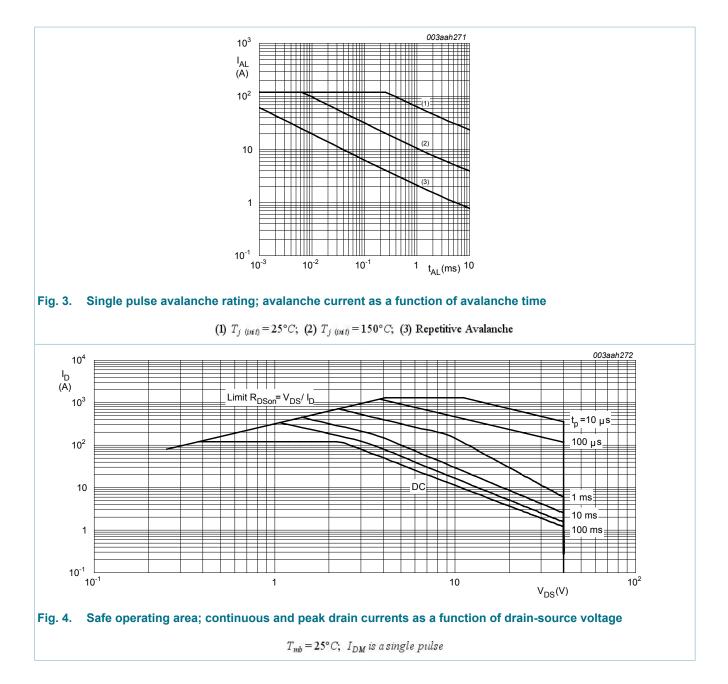




$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

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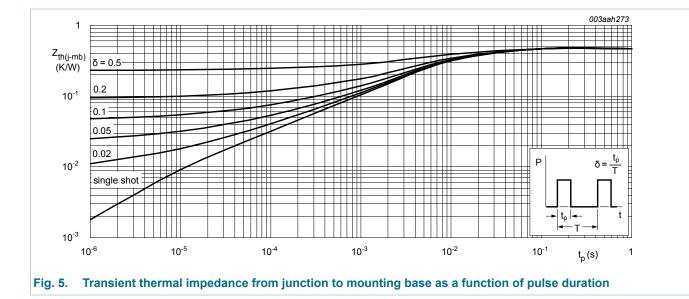
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6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. 5	-	-	0.46	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	minimum footprint ; mounted on a printed-circuit board	-	50	-	K/W

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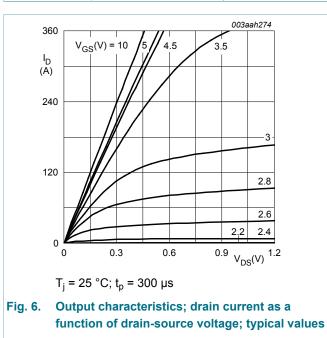


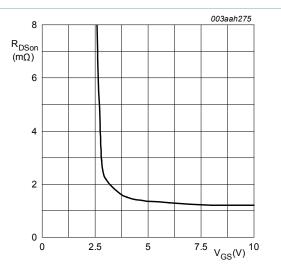
Characteristics 7.

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
Static chara	acteristics	1				
V _{(BR)DSS}	drain-source	I_D = 250 µA; V_{GS} = 0 V; T_j = 25 °C	40	-	-	V
	breakdown voltage	I_D = 250 µA; V_{GS} = 0 V; T_j = -55 °C	36	-	-	V
V _{GS(th)}	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; Fig. 9; Fig. 10	1.4	1.7	2.1	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ Fig. 9	-	-	- - - - 1.7 2.1 1.7 2.45 - 2.45 - - 0.15 1 - 500 2 100 2 100 1.35 1.7 1.2 3.26 - 3.26	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ Fig. 9	0.5	-	-	V
I _{DSS}	drain leakage current	V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	0.15	1	μA
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C	-	-	- 2.1 2.45 - 1 500 100 1.7 1.5 3.26	μA
I _{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state	V _{GS} = 5 V; I _D = 25 A; T _j = 25 °C; <u>Fig. 11</u>	-	1.35	1.7	mΩ
	resistance $V_{GS} = 10 \text{ V}; \text{ I}_D = 25 \text{ A}; \text{ T}_j = 25 \text{ °C};$ Fig. 11 $V_{GS} = 5 \text{ V}; \text{ I}_D = 25 \text{ A}; \text{ T}_j = 175 \text{ °C};$ Fig. 12; Fig. 11		-	1.2	1.5	mΩ
		,	-	-	3.26	mΩ
Dynamic ch	aracteristics	· · · ·	I			
Q _{G(tot)}	total gate charge	I_D = 25 A; V_{DS} = 32 V; V_{GS} = 5 V;	-	105.4	-	nC
Q _{GS}	gate-source charge	Fig. 13; Fig. 14	-	25.1	-	nC

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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Q _{GD}	gate-drain charge			-	36.6	-	nC
C _{iss}	input capacitance	V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;		-	11260	15010	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 15</u>		-	1390	1670	pF
C _{rss}	reverse transfer capacitance	55 55		-	730	1000	pF
t _{d(on)}	turn-on delay time	V_{DS} = 30 V; R _L = 1.2 Ω; V _{GS} = 5 V;		-	69	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega$		-	118	-	ns
t _{d(off)}	turn-off delay time			-	176	-	ns
t _f	fall time			-	106	-	ns
L _D	internal drain inductance			-	2.5	-	nH
L _S	internal source inductance	from source lead to source bonding pad		-	7.5	-	nH
Source-dra	in diode		1				
V _{SD}	source-drain voltage	I_{S} = 25 A; V_{GS} = 0 V; T_{j} = 25 °C; <u>Fig. 16</u>		-	0.78	1.2	V
t _{rr}	reverse recovery time	$I_{\rm S}$ = 20 A; dI_{\rm S}/dt = -100 A/µs; V _{GS} = 0 V;		-	46.5	-	ns
Qr	recovered charge	V _{DS} = 25 V		-	58.5	-	nC



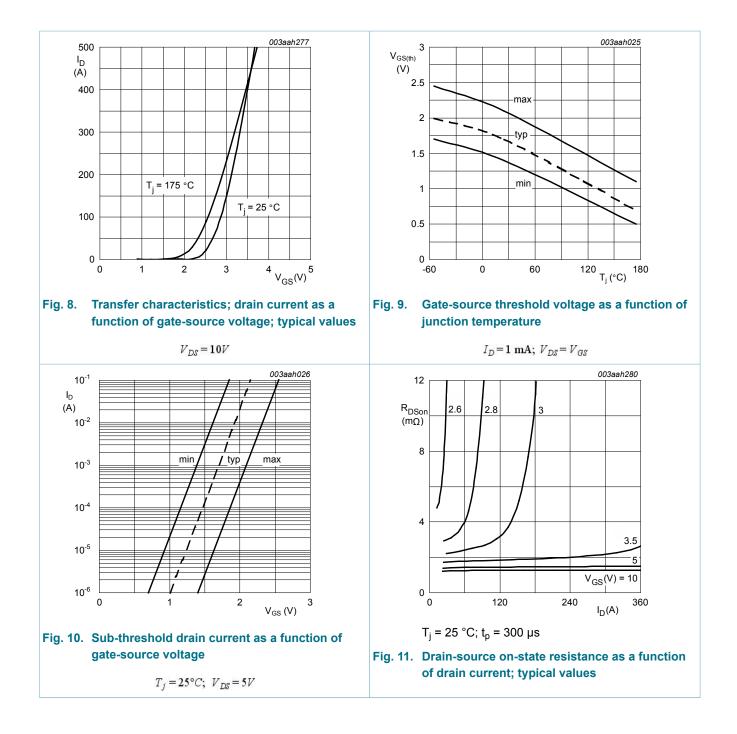




 $T_j = 25^{\circ}C; \ I_D = 25A$

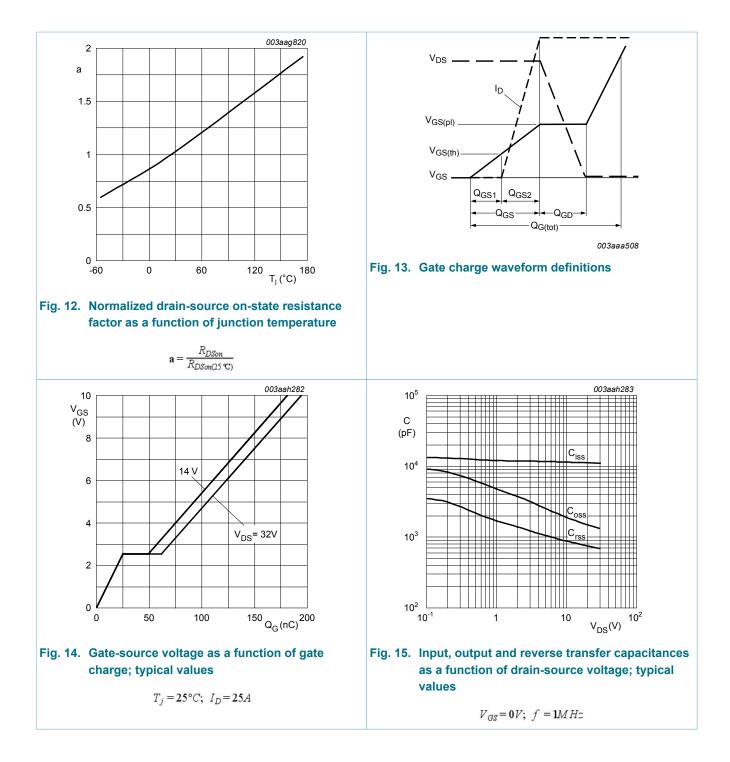
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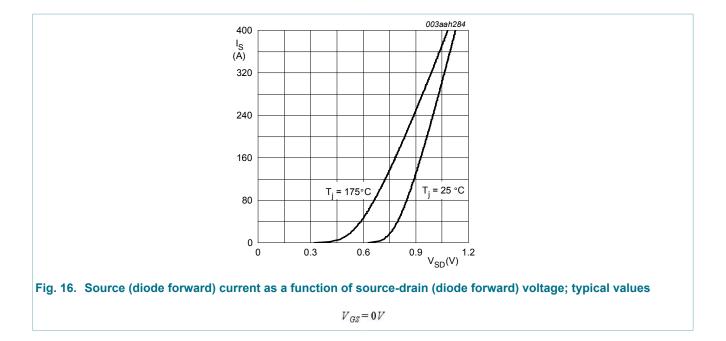
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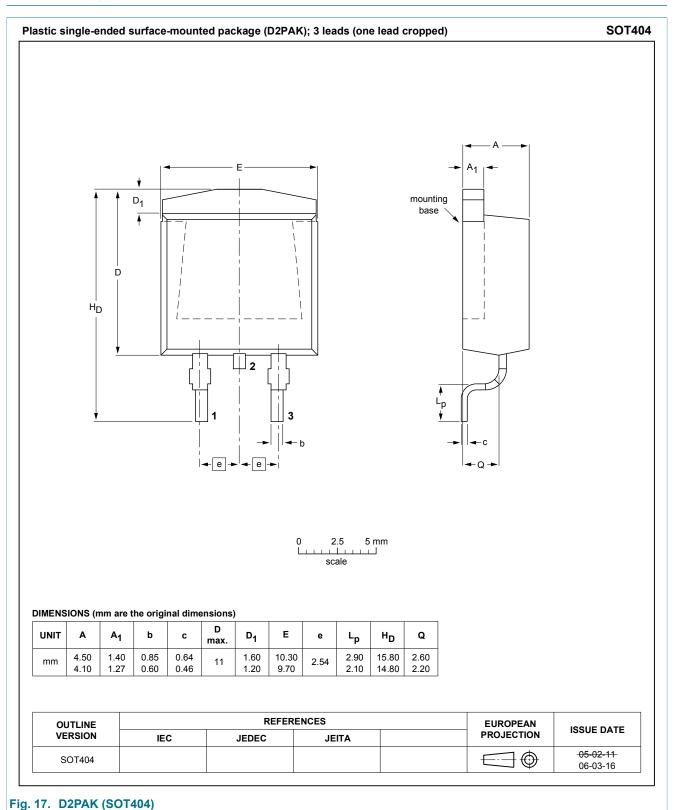
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8. Package outline



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9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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